

**Search Notes**

Application/Control No.

10/775,239

Examiner

Rita Leykin

Applicant(s)/Patent under  
Reexamination

ISHIKAWA ET AL.

Art Unit

2837

**SEARCHED**

Class	Subclass	Date	Examiner
318	376	4/14/2006	R.L.
	375		
	139		
320	124		
307	9.1		
	48		
	74		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
318	376	4/14/2006	R.L.
	375		
	139		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, DERWENT, EPO, JPO USPGPUB	4/14/2006	R.L.